Power MOSFET

20 V, 7.2 A, N-Channel ChipFET™

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space
- Pb-Free Package is Available

Applications

• Power Management in Portable and Battery-Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

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Rating	Symbol	5 Secs	Steady State	Unit
Drain-Source Voltage	V_{DS}	2	0	V
Gate-Source Voltage	V_{GS}	±12		V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I _D	7.2 5.2	5.2 3.8	А
Pulsed Drain Current	I _{DM}	±20		Α
Continuous Source Current (Diode Conduction) (Note 1)	I _S	7.2	5.2	Α
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.5 1.3	1.3 0.7	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	–55 to	+150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

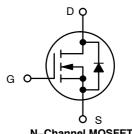
 Surface Mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



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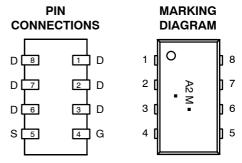
V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX	
20 V	25 mΩ @ 4.5 V	7.2 A	



N-Channel MOSFET



ChipFET CASE 1206A STYLE 1



A2 = Specific Device Code

M = Month Code

■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTHS5404T1	ChipFET	3000/Tape & Reel
NTHS5404T1G	ChipFET (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
$\label{eq:maximum Junction-to-Ambient (Note 2)} $$t \leq 5 sec $$ Steady State $$$	$R_{ hetaJA}$	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R_{\thetaJF}	15	20	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic Symbol Test Condition		Min	Тур	Max	Unit	
DYNAMIC (Note 4)			•	•		•
Total Gate Charge	Q_{G}			12	18	nC
Gate-Source Charge	Q _{GS}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V},$ $I_{D} = 5.2 \text{ A}$		2.4		1
Gate-Drain Charge	Q _{GD}	.0 -:=::		3.2		1
Input Capacitance	C _{ISS}			740		pF
Output Capacitance	C _{OSS}	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		337		1
Reverse Transfer Capacitance	C _{RSS}			88		1
Turn-On Delay Time	t _{d(on)}			8.0	15	ns
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_L = 10 \Omega$		7.0	15	1
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A}, V_{GEN} = 4.5 \text{ V},$ $R_G = 6 \Omega$		50	60	1
Fall Time	t _f			28	40	1
STATIC				•		•
Drain-to-Source Breakdown Voltage (Note 3)	V _{(BR)DSS}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	20	25.1		V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J			18.4		mV/°C
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.6	1		V
Gate-Body Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = \pm 12 V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V			1.0	μΑ
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, $ $T_{J} = 85^{\circ}\text{C}$			5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \ge 5.0 \text{ V}, V_{GS} = 4.5 \text{ V}$ 20		1		Α
Drain-Source On-State Resistance	r _{DS(on)}	V _{GS} = 4.5 V, I _D = 5.2 A		0.025	0.030	Ω
(Note 3)		$V_{GS} = 2.5 \text{ V}, I_D = 4.3 \text{ A}$		0.038	0.045	1
Forward Transconductance (Note 3)	9 _{fs}	V _{DS} = 10 V, I _D = 5.2 A		20		S
DRAIN-SOURCE DIODE CHARACTERI	STICS					
Forward Diode Voltage (Note 3)	V _{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 5.2 \text{ A}$		0.8	1.2	V
Reverse Recovery Time	t _{rr}			20.9		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V}, I_S = 5.2 \text{ A},$		10.2		1
Discharge Time	t _b	$di_S/dt = 100 A/\mu s$		10.6		1
Reverse Recovery Time	Q _{rr}			11		nC

Surface Mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

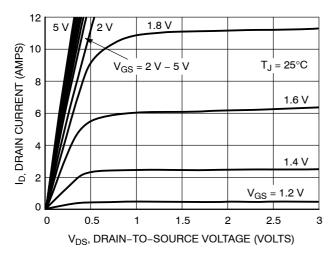


Figure 1. On-Region Characteristics

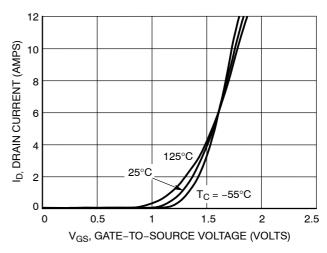


Figure 2. Transfer Characteristics

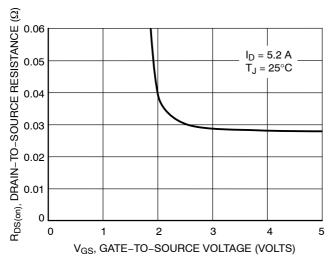


Figure 3. On-Resistance versus Gate-to-Source Voltage

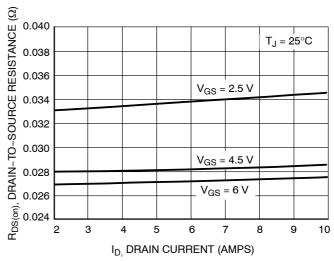


Figure 4. On-Resistance versus Drain Current and Gate Voltage

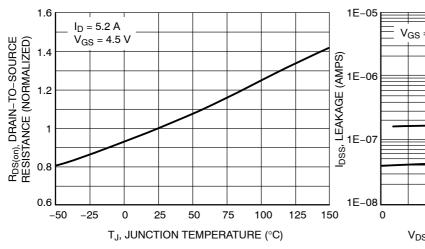


Figure 5. On–Resistance Variation with Temperature

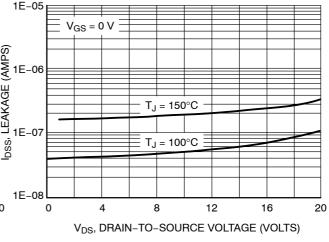
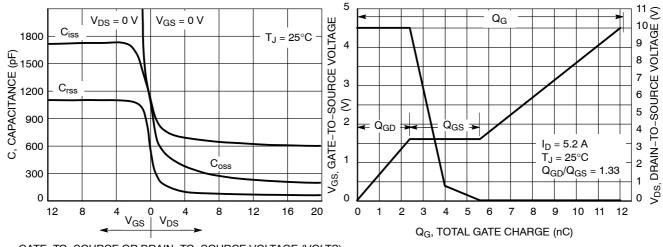


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

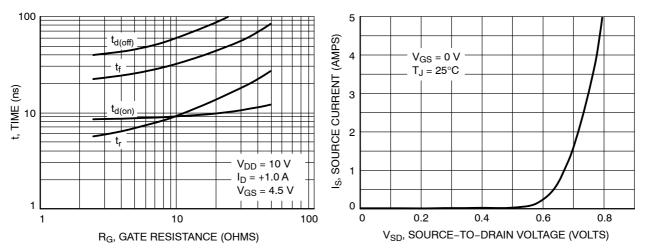


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus
Current

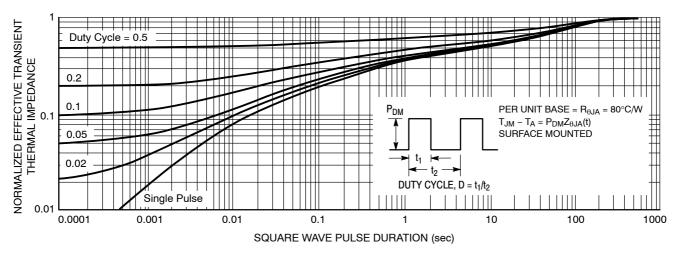


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

SOLDERING FOOTPRINT*

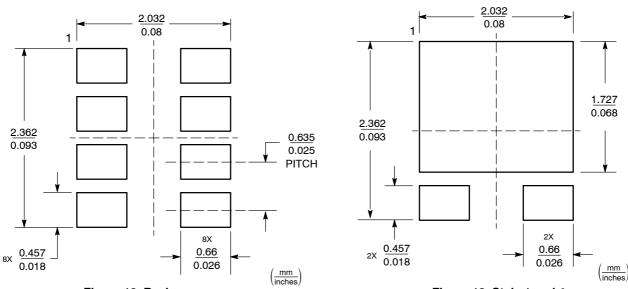
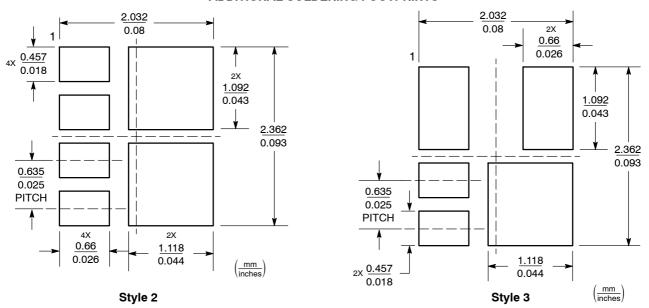


Figure 12. Basic

Figure 13. Style 1 and 4

ADDITIONAL SOLDERING FOOTPRINTS*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

BASIC PAD PATTERNS

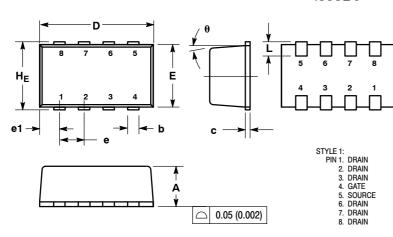
The basic pad layout with dimensions is shown in Figure 12. This is sufficient for low power dissipation MOSFET applications, but power semiconductor performance requires a greater copper pad area, particularly for the drain leads.

The minimum recommended pad pattern shown in Figure 13 improves the thermal area of the drain connections (pins 1, 2, 3, 6, 7, 8) while remaining within the

confines of the basic footprint. The drain copper area is 0.0054 sq. in. (or 3.51 sq. mm). This will assist the power dissipation path away from the device (through the copper lead–frame) and into the board and exterior chassis (if applicable) for the single device. The addition of a further copper area and/or the addition of vias to other board layers will enhance the performance still further.

PACKAGE DIMENSIONS

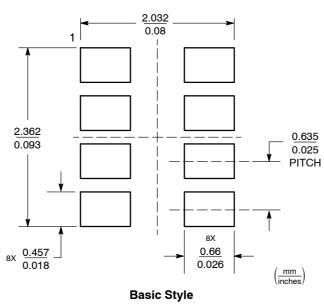
ChipFET™ CASE 1206A-03 **ISSUE J**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL
- AND VERTICAL SHALL NOT EXCEED 0.08 MM. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.025 BSC			
e1	1 0.55 BSC			0.022 BSC			
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ	5° NOM			5° NOM			

SOLDERING FOOTPRINT



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